Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	-
10/681,647	KIM ET AL.	
Examiner	Art Unit	
Hiep Nguyen	2816	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
327	407	09.02.05	M	
	408	-	1	
	5%	_	J	
pgpub	Search	09.06.05	M	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	09.02.05	Mh	
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227/407, 408,580.cclo. and (divid\$4 and fus\$3)	09.02.05	M	
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